Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,056	KRVAVAC ET AL.
Examiner	Art Unit
Henry K. Choe	2817

SEARCHED				
Class	Subclass	Date	Examiner	
37 =	3.7	6/18/05	И. «.	
"/	9	1.1	. ,	
٠,	rer	ν, 1	`,	
١.	~95	. 1	`,	
• •	84	6/20/05	١,	
, ,	~96	11	. 1	
4p Lit	1 seach	1/18/01	H- < .	
		,		
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Searce	nel abor	e 1/18/6	6 H-c.	
See	stack	next '		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Test scart (Fast)	6/20/2	The,	
NPL (IEEE)	. 11	"	